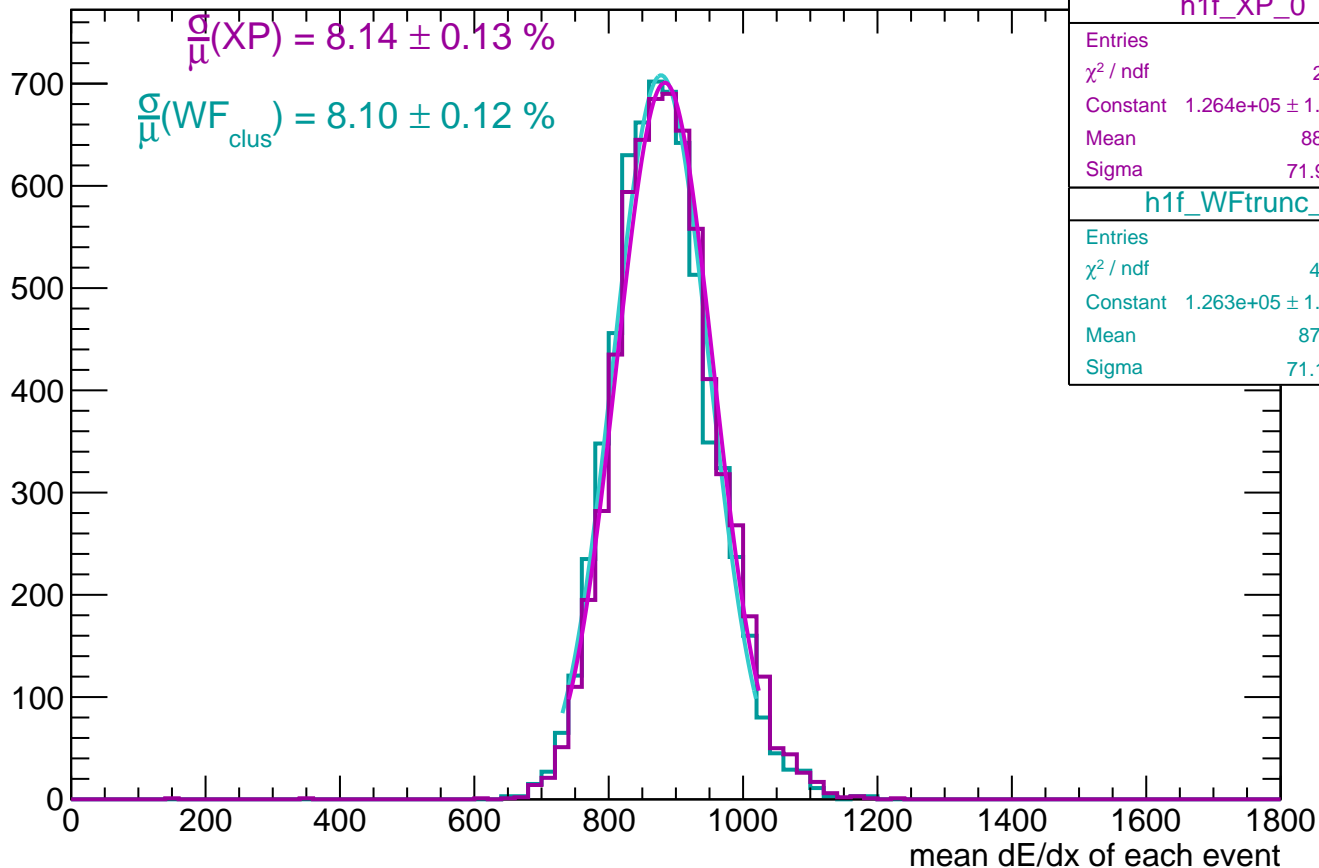Mean dE/dx with electron_z760

$\frac{\sigma}{\mu}(XP) = 8.14 \pm 0.13$ %

$\frac{\sigma}{\mu}(WF_{clus}) = 8.10 \pm 0.12$ %

h1f_XP_0	
Entries	6386
χ^2 / ndf	27.68 / 11
Constant	$1.264e{+}05 \pm 1.700e{+}03$
Mean	883.6 ± 1.1
Sigma	71.94 ± 1.09

h1f_WFtrunc_0	
Entries	6386
χ^2 / ndf	45.97 / 12
Constant	$1.263e{+}05 \pm 1.660e{+}03$
Mean	877.9 ± 1.0
Sigma	71.14 ± 0.97

Counts

mean dE/dx of each event

XP vs WF$_{cluster}$ <dE/dx> (selected data, module 0)

h2f_XPvsWF_0		
Entries		0
Mean x		0
Mean y		0
Std Dev x		0
Std Dev y		0
0	0	0
0	0	0
0	0	0

WF$_{\text{not trunc}}$ - WF$_{\text{trunc}}$ vs WF$_{\text{not trunc}}$ (module 0)

h2f_WFmWFvsWF_0		
Entries		0
Mean x		0
Mean y		0
Std Dev x		0
Std Dev y		0
0	0	0
0	0	0
0	0	0

y-axis: WF$_{\text{not trunc}}$ - WF$_{\text{trunc}}$ <dE/dx> (ADC count)

x-axis: WF$_{\text{not trunc}}$ <dE/dx> (ADC count)